



Advanced Power
Electronics Corp.

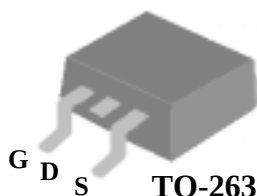
AP40N03GS

Pb Free Plating Product

N-CHANNEL ENHANCEMENT MODE

POWER MOS FET

- ▼ Low Gate Charge
- ▼ Simple Drive Requirement
- ▼ Fast Switching

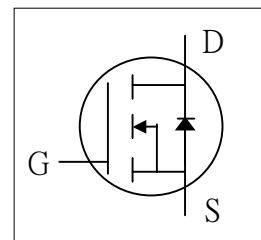


BV_{DSS}	30V
$R_{DS(ON)}$	17m Ω
I_D	40A

Description

The Advanced Power MOSFETs from APEC provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-263 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters. The through-hole version (AP40N03GP) is available for low-profile applications.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	30	V
V_{GS}	Gate-Source Voltage	± 20	V
$I_D@T_C=25^{\circ}C$	Continuous Drain Current, V_{GS} @ 10V	40	A
$I_D@T_C=100^{\circ}C$	Continuous Drain Current, V_{GS} @ 10V	30	A
I_{DM}	Pulsed Drain Current ¹	169	A
$P_D@T_C=25^{\circ}C$	Total Power Dissipation	50	W
	Linear Derating Factor	0.4	W/ $^{\circ}C$
T_{STG}	Storage Temperature Range	-55 to 150	$^{\circ}C$
T_J	Operating Junction Temperature Range	-55 to 150	$^{\circ}C$

Thermal Data

Symbol	Parameter	Value	Unit
Rthj-c	Thermal Resistance Junction-case Max.	2.5	$^{\circ}C/W$
Rthj-a	Thermal Resistance Junction-ambient Max.	62	$^{\circ}C/W$



AP40N03GS

Electrical Characteristics@T_j=25°C(unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250uA	30	-	-	V
ΔBV _{DSS} /ΔT _j	Breakdown Voltage Temperature Coefficient	Reference to 25°C, I _D =1mA	-	0.037	-	V/°C
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =20A	-	14	17	mΩ
		V _{GS} =4.5V, I _D =16A	-	20	23	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250uA	1	-	3	V
g _{fs}	Forward Transconductance	V _{DS} =10V, I _D =20A	-	26	-	S
I _{DSS}	Drain-Source Leakage Current (T _j =25°C)	V _{DS} =30V, V _{GS} =0V	-	-	1	uA
	Drain-Source Leakage Current (T _j =150°C)	V _{DS} =24V, V _{GS} =0V	-	-	25	uA
I _{GSS}	Gate-Source Forward Leakage	V _{GS} = ± 20V	-	-	±100	nA
Q _g	Total Gate Charge ²	I _D =20A	-	17	-	nC
Q _{gs}	Gate-Source Charge	V _{DS} =24V	-	3	-	nC
Q _{gd}	Gate-Drain ("Miller") Charge	V _{GS} =5V	-	10	-	nC
t _{d(on)}	Turn-on Delay Time ²	V _{DS} =15V	-	7.2	-	ns
t _r	Rise Time	I _D =20A	-	60	-	ns
t _{d(off)}	Turn-off Delay Time	R _G =3.3Ω, V _{GS} =10V	-	22.5	-	ns
t _f	Fall Time	R _D =0.75Ω	-	10	-	ns
C _{iss}	Input Capacitance	V _{GS} =0V	-	800	-	pF
C _{oss}	Output Capacitance	V _{DS} =25V	-	380	-	pF
C _{rss}	Reverse Transfer Capacitance	f=1.0MHz	-	133	-	pF

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
I _S	Continuous Source Current (Body Diode)	V _D =V _G =0V , V _S =1.3V	-	-	40	A
I _{SM}	Pulsed Source Current (Body Diode) ¹		-	-	169	A
V _{SD}	Forward On Voltage ²	T _j =25°C , I _S =40A, V _{GS} =0V	-	-	1.3	V

Notes:

1.Pulse width limited by safe operating area.

2.Pulse width ≤300us , duty cycle ≤2%.

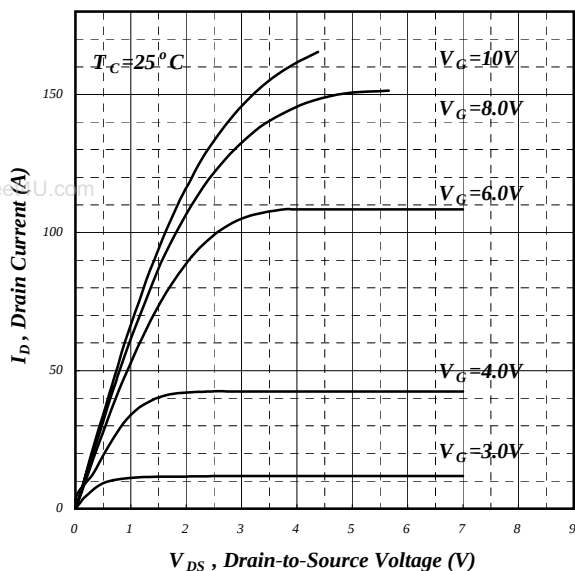


Fig 1. Typical Output Characteristics

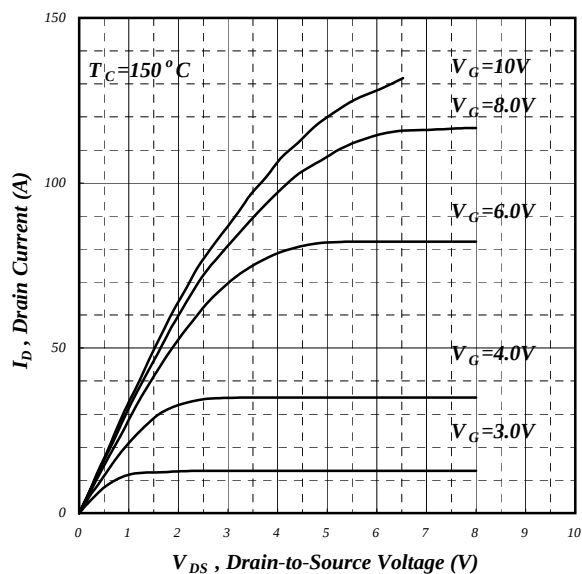


Fig 2. Typical Output Characteristics

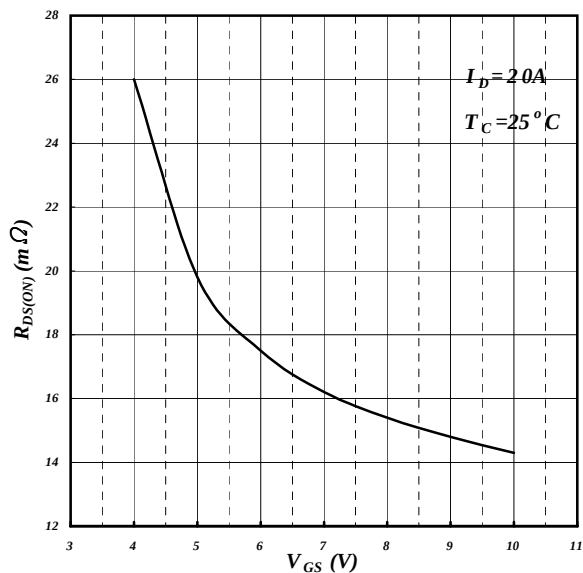


Fig 3. On-Resistance v.s. Gate Voltage

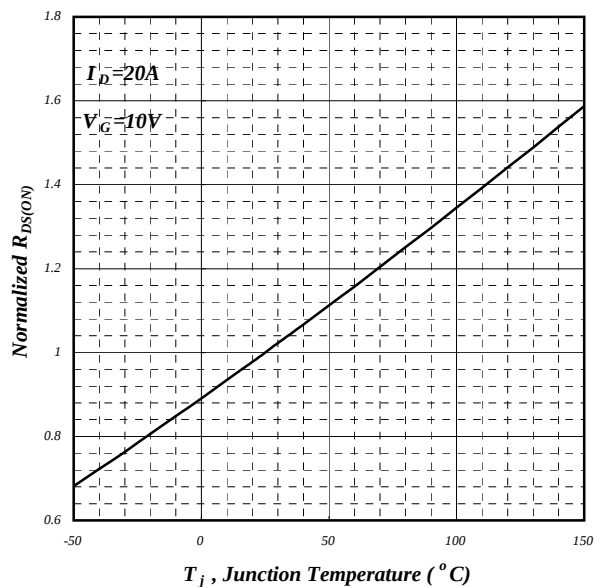


Fig 4. Normalized On-Resistance v.s. Junction Temperature



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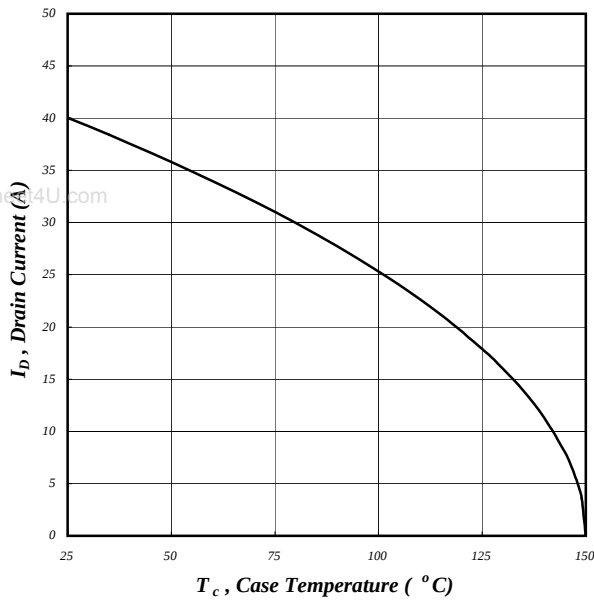


Fig 5. Maximum Drain Current v.s. Case Temperature

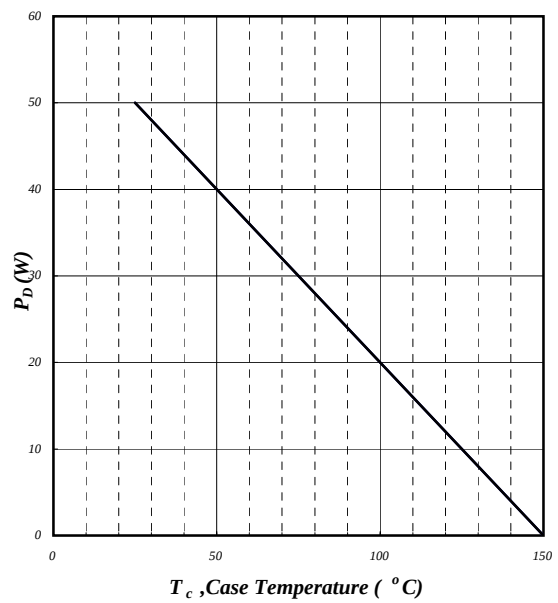


Fig 6. Typical Power Dissipation

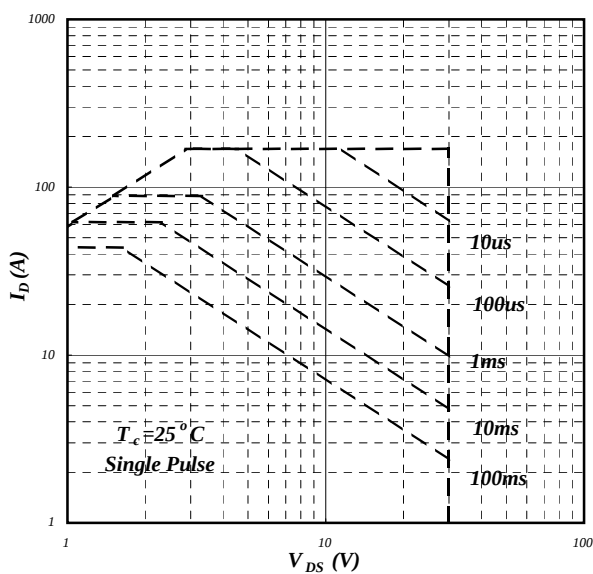


Fig 7. Maximum Safe Operating Area

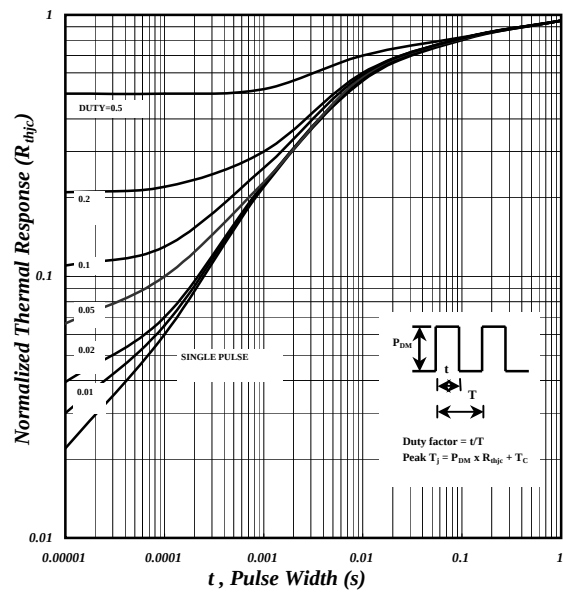
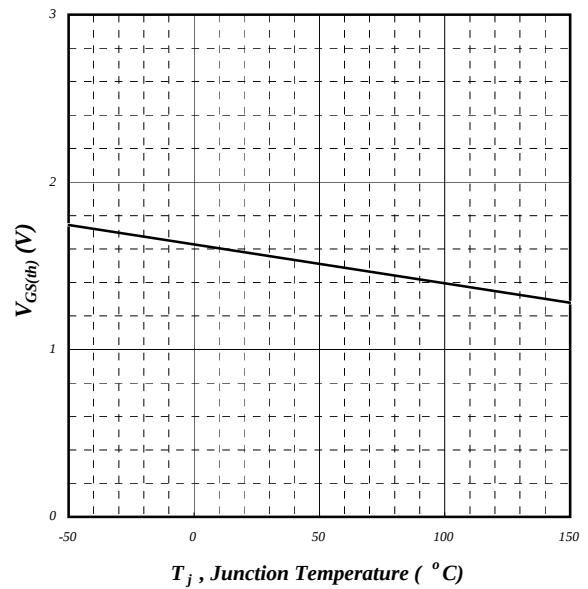
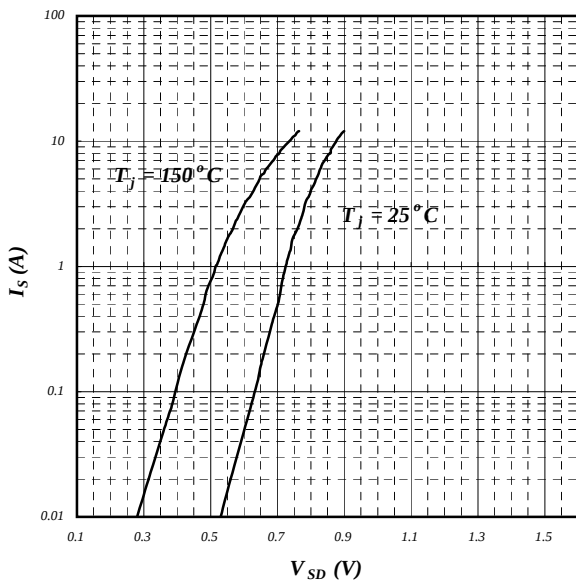
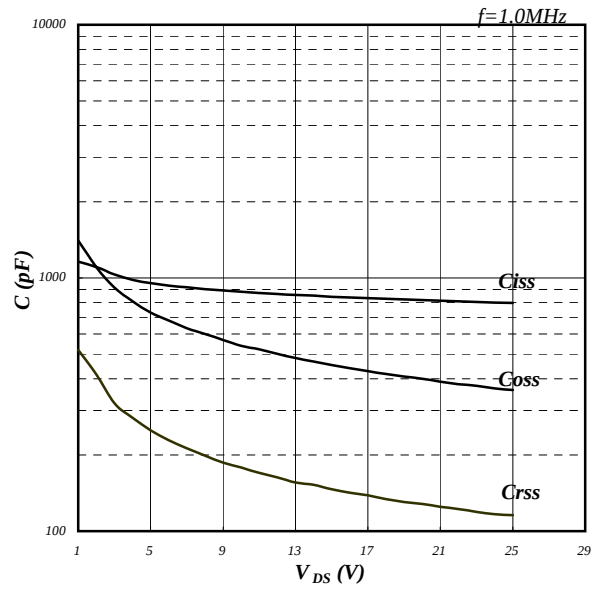
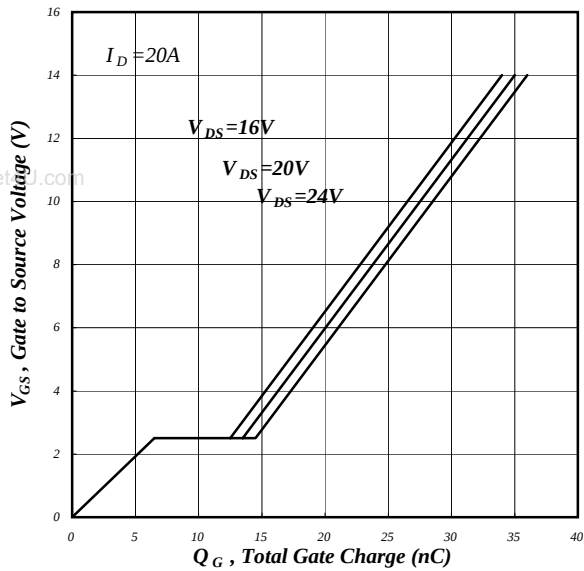


Fig 8. Effective Transient Thermal Impedance



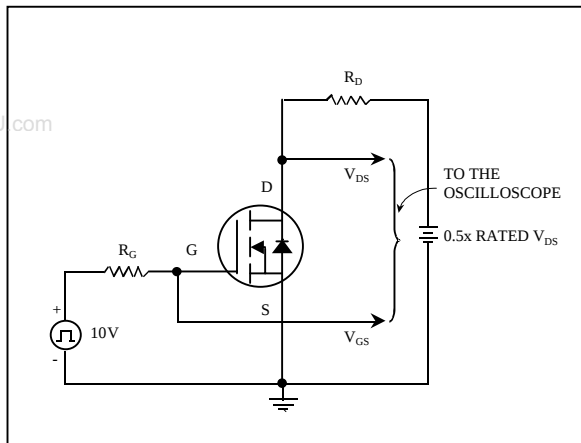


Fig 13. Switching Time Circuit

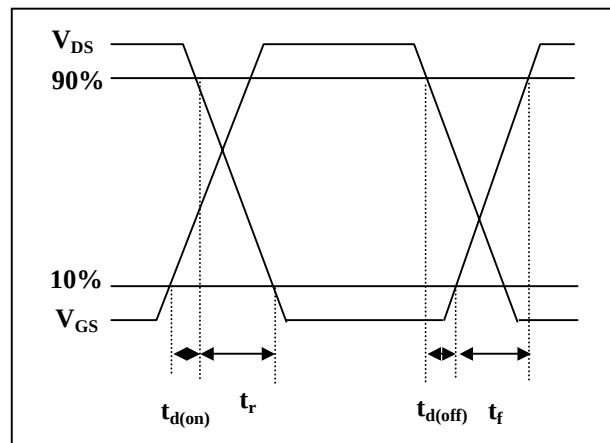


Fig 14. Switching Time Waveform

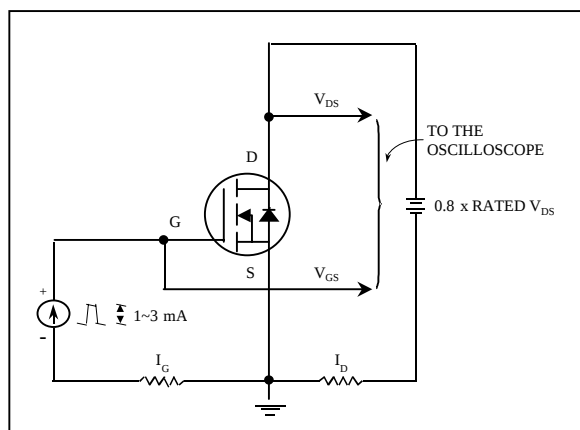


Fig 15. Gate Charge Circuit

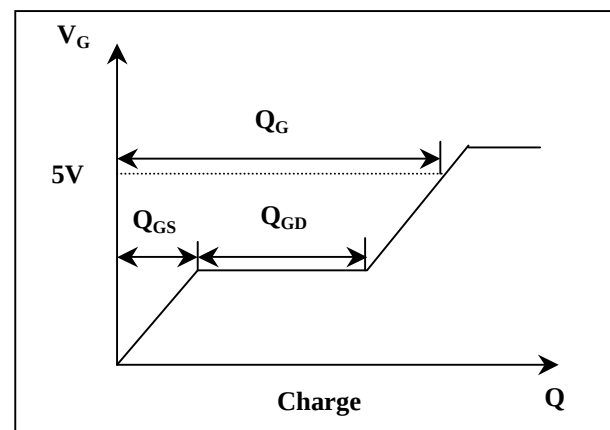


Fig 16. Gate Charge Waveform